


<b>Search Notes</b>  	<b>Application/Control No.</b>  09995378	<b>Applicant(s)/Patent Under Reexamination</b>  OHNO, TOMOYUKI
	<b>Examiner</b>  Huynh, Son P	<b>Art Unit</b>  2623

SEARCHED			
Class	Subclass	Date	Examiner
UPDATE SEARCH		11/10/06	AH
725	39-41,43-44,52	11/10/06	AH
update search			
725	40-44	6/7/07	AH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST TEXT SEARCH ENCLOSED	11/10/06	AH
update East text search enclosed	6/7/07	AH
Scott Beliveau, Michael Hoyer, Ngoc Vu, Rueben Brown (all in 725), QEM, Vivek Srivastava	6/7/07	AH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner